

Form PTO-1449	ATTY DOCKET NO. 0171-0826P	APPLICATION NO. 10/082,315
INFORMATION DISCLOSURE CITATION IN AN APPLICATION (Use several sheets if necessary)		
FILING DATE August 7, 2002		
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U. S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION	
						YES	NO
Ym	0 840 386 A	1998-05-06	EP				
Ym	0 216 649 A	1987-04-01	EP				

OTHER DOCUMENTS (Include Name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.) date, page(s), volume-issue number(s), publisher, city and/or country where published.)

afw	DATABASE WPI, Section Ch, Week 200207 Derwent Publications Ltd., London, GB; Class L02, AN 2002-051162 XP002201123 & JP 2001 226112 A (SHINETSU CHEM IND CO LTD), 21 August 2001 (2001-08-21) *abstract*
ym	DATABASE WPI, Section Ch, Week 200163 Derwent Publications Ltd., London, GB; Class E36, AN 2001-560341 XP002201124 & JP 2001 158613 A (DENKI KAGAKU KOGYO KK), 12 June 2001 (2001-06-12) *abstract*
ym	DATABASE WPI, Section Ch, Week 200158 Derwent Publications Ltd., London, GB; Class L03, AN 2001-524965 XP002201125 & JP 2001 118568 A (DENKI KAGAKU KOGYO KK), 27 April 2001 (2001-04-27) *abstract*
ym	PATENT ABSTRACTS OF JAPAN, Vol. 2000, No. 24, 11 May 2001 (2001-05-11) & JP 2001 185125 A (DENKI KAGAKU KOGYO KK), 6 July 2001 (2001-07-06) *abstract*
ym	PATENT ABSTRACTS OF JAPAN, Vol. 2000, No. 24, 11 May 2001 (2001-05-11) & JP 2001 199716 A (DENKI KAGAKU KOGYO KK), 24 July 2001 (2001-07-24) *abstract*
ym	DATABASE CA 'Online! CHEMICAL ABSTRACTS SERVICE, COLUMBUS, OHIO, US; ECKERT, HANS J. et al.: "Studies on silicon oxides" retrieved from STN database accession no. 86:46630 CA XP002201140 *abstracts* & WISS. Z., TECH. HOCHSCH., KARL-MARX STADT (1976), 18(1), 103-12, 1976

EXAMINER	DATE CONSIDERED
<i>Mark J. Kenyon</i>	11/28/03

EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

